



## **General Description**

The WSF15N10A uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

### **Product Summery**

BVDSS	RDSON	ID
100V	90mΩ	15A

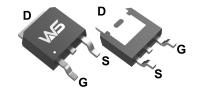
#### **Features**

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E<sub>AS</sub>
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

## **Application**

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

## **TO-252 Pin Configuration**





## **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage	100	V	
$V_{GS}$	Gate-Source Voltage	±20	\ \	
I <sub>D</sub> @T <sub>C</sub> =25℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	15	Α	
I <sub>D</sub> @T <sub>C</sub> =100℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	7	Α	
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	40	Α	
P <sub>D</sub> @T <sub>C</sub> =25℃	Maximum Power Dissipation	40	W	
	Derating factor	0.27	W/°C	
EAS	Single Pulse Avalanche Energy <sup>3</sup>	20	mJ	
T <sub>J</sub> T <sub>STG</sub>	Operating Junction Temperature Range	-55 to 170	°C	

#### **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit	
R <sub>0JA</sub>	Thermal Resistance Junction-ambient <sup>1</sup>		50	°C/W	
$R_{ heta JC}$	Thermal Resistance Junction-Case <sup>1</sup>		3.8	°C/W	



**N-Ch MOSFET** 

# Electrical Characteristics (T<sub>J</sub>=25 C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS}$ =0V , $I_D$ =250uA	100			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25℃, I <sub>D</sub> =1mA		0.098		V/°C
D	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V , I <sub>D</sub> =5A		90	110	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS}$ =4.5V , $I_D$ =2A		110	150	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}$ = $V_{DS}$ , $I_D$ =250uA	1.0	1.5	2.5	V
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{DS}$ =80V , $V_{GS}$ =0V , $T_J$ =25 $^{\circ}$ C			1	nA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ = $\pm 20 V$ , $V_{DS}$ = $0 V$			±100	uA
gfs	Forward Transconductance	$V_{DS}$ =5V , $I_D$ =5A	3.5			S
Qg	Total Gate Charge (10V)			21.5		
$Q_gs$	Gate-Source Charge	$V_{DS}$ =50V , $V_{GS}$ =10V , $I_{D}$ =5A		3.2		nC
$Q_{gd}$	Gate-Drain Charge			6.0		
$T_{d(on)}$	Turn-On Delay Time			11	24	
Tr	Rise Time	$V_{DD}$ =30V , $V_{GS}$ =10V , $R_{G}$ =6 $\Omega$		7.4	15	20
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =1A , R <sub>L</sub> =30Ω		35	45	ns
T <sub>f</sub>	Fall Time			9.1	12	
C <sub>iss</sub>	Input Capacitance			730	980	
Coss	Output Capacitance	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , f=1MHz		37	55	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			27	35	

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			10	Α
$V_{SD}$	Diode Forward Voltage <sup>2</sup>	$V_{GS}$ =0V , $I_{S}$ =10A , $T_{J}$ =25 $^{\circ}$ C			1.2	V
t <sub>rr</sub>	Reverse Recovery Time	-IF=10A,dI/dt=100A/μs,T <sub>J</sub> =25℃	17	21	61	nS
Q <sub>rr</sub>	Reverse Recovery Charge		61	97	113	nC

## Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board,  $t\,\leqslant\,$  10 sec.
- 3. Pulse Test: Pulse Width  $\,\leqslant\,\,$  300 +s, Duty Cycle  $\,\leqslant\,\,$  2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS conditionpÉTj=25°C, $V_{DD}$ =50V, $V_{G}$ =10V,L=0.5mH,Rg=25



## **Typical Characteristics**

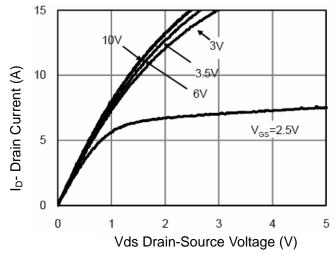
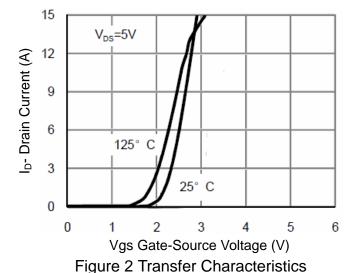


Figure 1 Output Characteristics



Mgson On-Resistance (mg) 140

120

V<sub>GS</sub>=4.5V

V<sub>GS</sub>=10V

Figure 3 Rdson- Drain Current

I<sub>D</sub>- Drain Current (A)

6

8

2

0

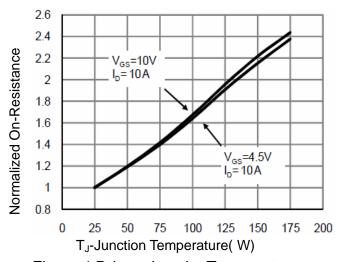
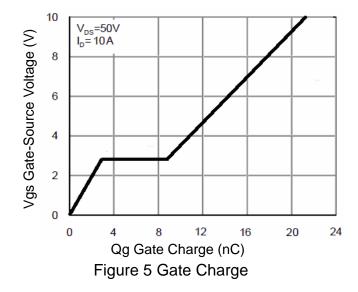


Figure 4 Rdson-JunctionTemperature



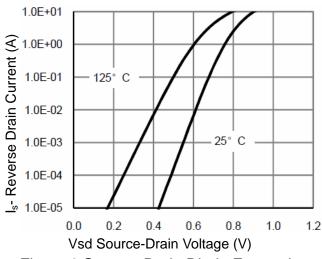


Figure 6 Source- Drain Diode Forward

10



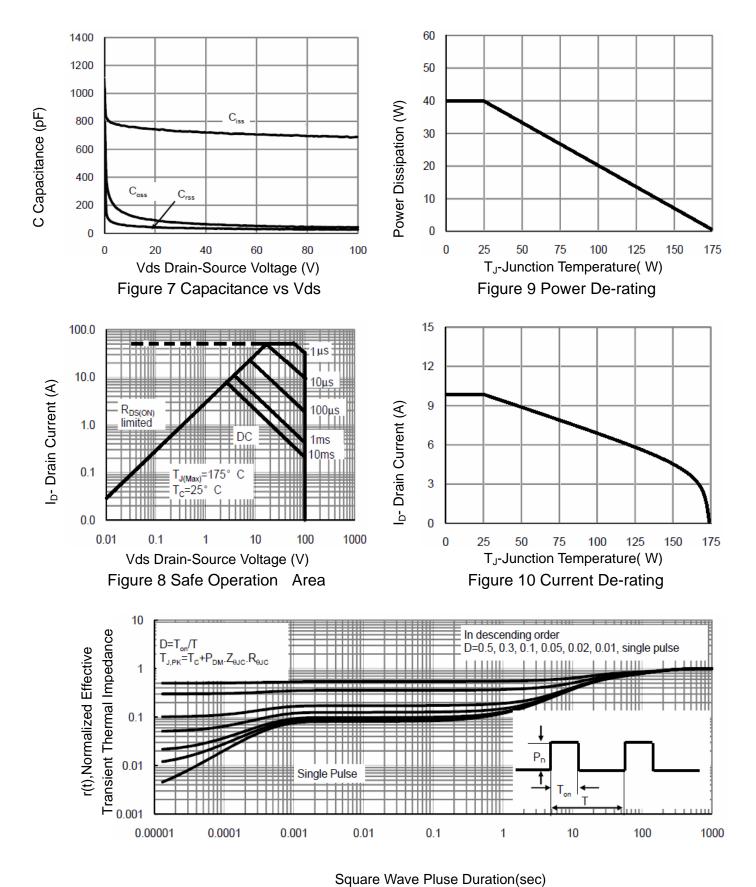


Figure 11 Normalized Maximum Transient Thermal Impedance



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